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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
09/745,914	12/22/2000	Antonius Henricus Maria Raaijmakers	PHN 17,819	2618
24737 75	90 09/08/2004		EXAM	INER
PHILIPS INT	ELLECTUAL PROPE	CHUNG, DAVID Y		
P.O. BOX 3001	ADD COURT DARROWS AND CO.			
BRIARCLIFF	BRIARCLIFF MANOR, NY 10510			- THE ENTONIBER
			DATE MAILED: 09/08/200	4

Please find below and/or attached an Office communication concerning this application or proceeding.

		Application No.	Applicant(s)			
		09/745,914	RAAIJMAKERS ET AL.			
Office Action Summary		Examiner	Art Unit			
		David Y. Chung	2871			
Period fo	The MAILING DATE of this communication ap	ppears on the cover sheet w	ith the correspondence address			
A SH THE - Exte after - If the - If NO - Failu Any	MAILING DATE OF THIS COMMUNICATION ensions of time may be available under the provisions of 37 CFR 1 r SIX (6) MONTHS from the mailling date of this communication. e period for reply specified above is less than thirty (30) days, a reply period for reply is specified above, the maximum statutory period ure to reply within the set or extended period for reply will, by staturely received by the Office later than three months after the mailined patent term adjustment. See 37 CFR 1.704(b).	. 136(a). In no event, however, may a ply within the statutory minimum of thi will apply and will expire SIX (6) MOI te, cause the application to become A	reply be timely filed rty (30) days will be considered timely. NTHS from the mailing date of this communication. BANDONED (35 U.S.C. § 133).			
Status						
	Responsive to communication(s) filed on <u>17</u> . This action is FINAL . 2b) This					
	This action is FINAL . 2b) This action is non-final. Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.					
Disposit	ion of Claims					
5)□ 6)⊠ 7)□	Claim(s) <u>1,2 and 4-6</u> is/are pending in the apple 4a) Of the above claim(s) is/are withdray Claim(s) is/are allowed. Claim(s) <u>1,2 and 4-6</u> is/are rejected. Claim(s) is/are objected to. Claim(s) are subject to restriction and/	awn from consideration.				
Applicat	ion Papers					
10)	The specification is objected to by the Examine The drawing(s) filed on is/are: a) ac Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct The oath or declaration is objected to by the Examine The specification is objected to be specification to the specification is objected to be specification.	cepted or b) objected to e drawing(s) be held in abeya ction is required if the drawing	nce. See 37 CFR 1.85(a). g(s) is objected to. See 37 CFR 1.121(d).			
Priority (under 35 U.S.C. § 119					
а)	Acknowledgment is made of a claim for foreig All b) Some * c) None of: 1. Certified copies of the priority documer 2. Certified copies of the priority documer 3. Copies of the certified copies of the pri application from the International Burea See the attached detailed Office action for a list	nts have been received. nts have been received in A ority documents have beer au (PCT Rule 17.2(a)).	Application No n received in this National Stage			
	nt(s) ce of References Cited (PTO-892) ce of Draftsperson's Patent Drawing Review (PTO-948)		Summary (PTO-413) . (s)/Mail Date			
3) 🔲 Infor	ce of Draftsperson's Patent Drawing Review (PTO-948) mation Disclosure Statement(s) (PTO-1449 or PTO/SB/08 er No(s)/Mail Date		Informal Patent Application (PTO-152)			

DETAILED ACTION

Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

1. Claims 1 and 2 rejected under 35 U.S.C. 103(a) as being unpatentable over Bird et al. (Sensors and Actuators 1995) in further view of Tanaka (JP 01-245226).

As to claim 1, Bird et al. discloses an image sensor pixel comprising a photosensitive element and a switching element. See figure 3. The photosensitive element and switching element comprise a layer of ITO formed over a layer of amorphous silicon. A silicon nitride layer covers the ITO layer at least partially. Since the silicon nitride layer covers the ITO layer, the ITO layer must be deposited prior to the silicon nitride layer.

Bird et al. does not disclose an intermediate layer of silicon oxide between the ITO layer and silicon nitride layer so that the switching element is completely shielded during manufacture. However, Tanaka et al. teaches forming a silicon oxide layer between an ITO layer and a silicon nitride layer in order to prevent the ITO layer from being reduced. See abstract. Note in figures 1 and 2, the silicon oxide layer 7 formed

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between the ITO layer 6 and silicon nitride layer 13. It would have been obvious to one of ordinary skill in the art at the time of invention to form an intermediate silicon oxide layer between the ITO layer and silicon nitride layer in figure 3 of Bird et al. in order to prevent the ITO layer from being reduced.

As to claim 2, Bird et al. does not suggest using the disclosed image sensor as a fingerprint sensor. However, it would have been obvious to one of ordinary skill in the art at the time of invention to use the image sensor disclosed by Bird et al. as a fingerprint sensor. The good quality images that can be obtained by the disclosed image sensor array make it well suited for achieving the level of detail and accuracy required by a fingerprint sensor. See page 444.

2. Claims 4-6 rejected under 35 U.S.C. 103(a) as being unpatentable over Bird et al. (Sensors and Actuators 1995) and Tanaka (JP 01-245226) as applied to claim 1 above and in further view of Tran et al. (U.S. 5,135,581).

As to claim 4, Bird et al. does not disclose a doped ITO layer. Tran et al. teaches doping transparent conductive oxides such as ITO with a stabilizing gas such as H₂. This reduces and stabilizes the resistivity and absorption characteristics of conductive oxide compositions formed at low temperatures. See column 3, lines 25-42. Tran et al. teaches depositing a conductive oxide onto photosensitive material at low temperatures to prevent diffusion of the oxide into the photosensitive material. See column 1, lines

54-65. It would have been obvious to one of ordinary skill in the art at the time of invention to dope the ITO layer in figure 3 of Bird et al. with a stabilizing gas in order to reduce and stabilize the resitivity and absorption characteristics.

Bird et al. does not disclose forming the silicon nitride layer using chemical vapor deposition. However, chemical vapor deposition (CVD) was a conventional technique that was well known for being cost-effective and reliable. It would have been obvious to one of ordinary skill in the art at the time of invention to form the silicon nitride layer using chemical vapor deposition because it was cost-effective and reliable.

As to claim 5, Tanaka et al. discloses forming the silicon oxide layer prior to forming the silicon nitride layer. See abstract and figure 1.

As to claim 6, Tanaka et al. teaches completely covering the ITO layer with the silicon oxide layer. Therefore, the ITO layer would be protected during manufacture of the silicon nitride layer.

Response to Arguments

Applicant's arguments filed April 26, 2004 have been fully considered but they are not persuasive. Examiner respectfully disagrees with applicant's assertion that Tanaka teaches away from that which is taught by Bird. Examiner sees no suggestion in Bird that only a portion of the ITO layer is appropriate for deposition of a silicon oxide layer. Examiner also respectfully disagrees with applicant's assertion that Tanaka

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teaches away from the claimed invention. Examiner submits that a silicon oxide layer with the same pattern as the ITO layer shown in figure 3 of Bird would completely shield the switching diode SD during manufacture as required by the claimed invention.

Conclusion

THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to David Chung whose telephone number is (571) 272-2288. The examiner can normally be reached on Monday-Friday from 8:30 am to 5:00 pm.

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David Chung GAU 2871 09/06/04